

<b>Notice of References Cited</b>	Application/Control No. 10/676,067		Applicant(s)/Patent Under Reexamination MATSUEDA ET AL.	
	Examiner Dieu Hien T. Duong		Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,633,135	10-2003	Nara et al.	315/169.3
*	B	US-2003/0076046	04-2003	Komiya et al.	315/169.3
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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